



**ALPHA & OMEGA**  
SEMICONDUCTOR

**AON2812**

**30V Dual N-Channel AlphaMOS**

### General Description

- Trench Power AlphaMOS ( $\alpha$ MOS LV) technology
- Low  $R_{DS(ON)}$
- Low Gate Charge
- ESD protection
- RoHS and Halogen-Free Compliant

### Applications

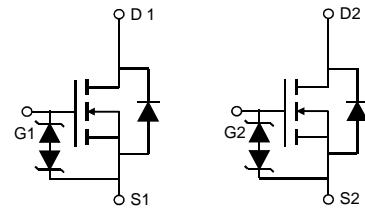
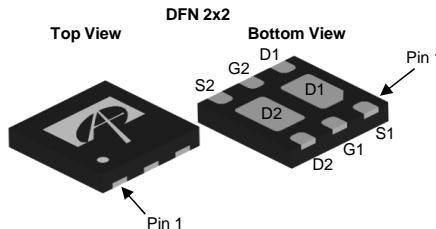
- Battery protection switch
- Mobile device battery charging and discharging
- Load switch

### Product Summary

$V_{DS}$	30V
$I_D$ (at $V_{GS}=10V$ )	4.5A
$R_{DS(ON)}$ (at $V_{GS}=10V$ )	< 37m $\Omega$
$R_{DS(ON)}$ (at $V_{GS}=4.5V$ )	< 45m $\Omega$
$R_{DS(ON)}$ (at $V_{GS}=2.5V$ )	< 70m $\Omega$

### Typical ESD protection

HBM Class 3A



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AON2812	DFN 2x2	Tape & Reel	3000

### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 12$	V
Continuous Drain Current <sup>G</sup>	$I_D$	4.5	A
$T_A=70^\circ\text{C}$		3.5	
Pulsed Drain Current <sup>C</sup>	$I_{DM}$	18	
Power Dissipation <sup>B</sup>	$P_D$	2.5	W
$T_A=70^\circ\text{C}$		1.6	
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	°C

### Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	40	50	°C/W
Maximum Junction-to-Ambient <sup>A,D</sup> Steady-State		65	80	°C/W

**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$\text{ID}=250\mu\text{A}, \text{VGS}=0\text{V}$	30			V
$\text{I}_{\text{DSS}}$	Zero Gate Voltage Drain Current	$\text{V}_{\text{DS}}=30\text{V}, \text{V}_{\text{GS}}=0\text{V}$ $\text{T}_J=55^\circ\text{C}$		1	5	$\mu\text{A}$
$\text{I}_{\text{GSS}}$	Gate-Body leakage current	$\text{V}_{\text{DS}}=0\text{V}, \text{V}_{\text{GS}}=\pm 10\text{V}$			$\pm 10$	$\mu\text{A}$
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_{\text{D}}=250\mu\text{A}$	0.6	1	1.4	V
$\text{R}_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$\text{V}_{\text{GS}}=10\text{V}, \text{I}_{\text{D}}=2\text{A}$ $\text{T}_J=125^\circ\text{C}$	30	37		$\text{m}\Omega$
		$\text{V}_{\text{GS}}=4.5\text{V}, \text{I}_{\text{D}}=1\text{A}$	41	50		
		$\text{V}_{\text{GS}}=2.5\text{V}, \text{I}_{\text{D}}=1\text{A}$	35	45		
			50	70		
$\text{g}_{\text{FS}}$	Forward Transconductance	$\text{V}_{\text{DS}}=5\text{V}, \text{I}_{\text{D}}=2\text{A}$		10		S
$\text{V}_{\text{SD}}$	Diode Forward Voltage	$\text{I}_{\text{S}}=1\text{A}, \text{V}_{\text{GS}}=0\text{V}$		0.75	1	V
$\text{I}_{\text{S}}$	Maximum Body-Diode Continuous Current				3	A
<b>DYNAMIC PARAMETERS</b>						
$\text{C}_{\text{iss}}$	Input Capacitance	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=15\text{V}, \text{f}=1\text{MHz}$		235		$\text{pF}$
$\text{C}_{\text{oss}}$	Output Capacitance			75		$\text{pF}$
$\text{C}_{\text{rss}}$	Reverse Transfer Capacitance			15		$\text{pF}$
$\text{R}_g$	Gate resistance	$\text{f}=1\text{MHz}$	4	8	12	$\Omega$
<b>SWITCHING PARAMETERS</b>						
$\text{Q}_g(10\text{V})$	Total Gate Charge	$\text{V}_{\text{GS}}=10\text{V}, \text{V}_{\text{DS}}=15\text{V}, \text{I}_{\text{D}}=2\text{A}$		4.5	10	nC
$\text{Q}_g(4.5\text{V})$	Total Gate Charge			2.2	6	nC
$\text{Q}_{\text{gs}}$	Gate Source Charge			0.3		nC
$\text{Q}_{\text{gd}}$	Gate Drain Charge			0.7		nC
$\text{t}_{\text{D(on)}}$	Turn-On DelayTime	$\text{V}_{\text{GS}}=10\text{V}, \text{V}_{\text{DS}}=15\text{V}, \text{R}_L=7.5\Omega, \text{R}_{\text{GEN}}=3\Omega$		3		ns
$\text{t}_r$	Turn-On Rise Time			3		ns
$\text{t}_{\text{D(off)}}$	Turn-Off DelayTime			24		ns
$\text{t}_f$	Turn-Off Fall Time			6		ns
$\text{t}_{\text{rr}}$	Body Diode Reverse Recovery Time	$\text{I}_{\text{F}}=2\text{A}, \text{dI}/\text{dt}=100\text{A}/\mu\text{s}$		7.2		ns
$\text{Q}_{\text{rr}}$	Body Diode Reverse Recovery Charge	$\text{I}_{\text{F}}=2\text{A}, \text{dI}/\text{dt}=100\text{A}/\mu\text{s}$		1.3		nC

A. The value of  $\text{R}_{\text{QJA}}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $\text{T}_A = 25^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $\text{T}_{\text{J(MAX)}}=150^\circ\text{C}$ , using  $\leq 10\text{s}$  junction-to-ambient thermal resistance.

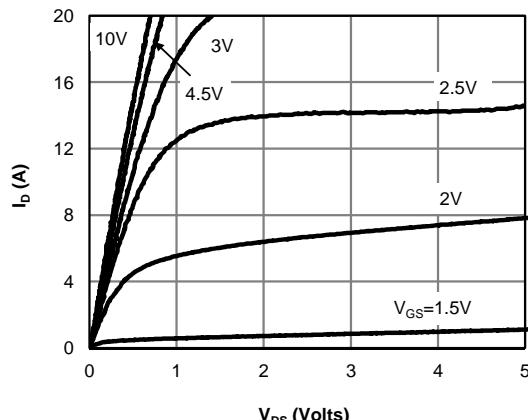
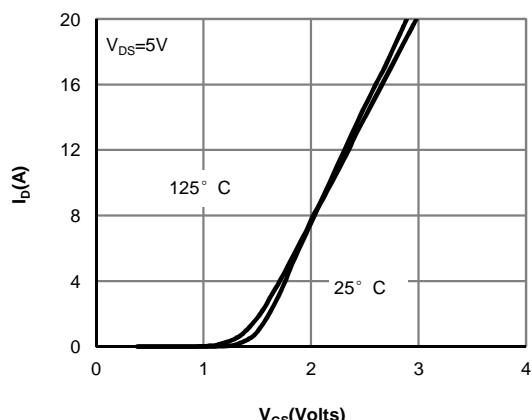
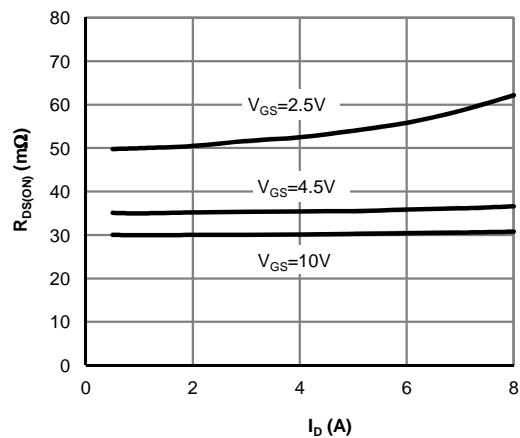
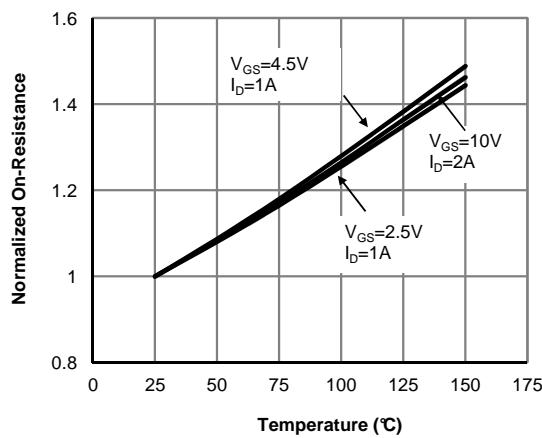
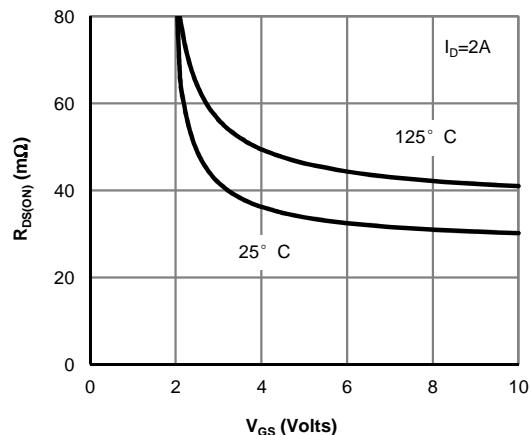
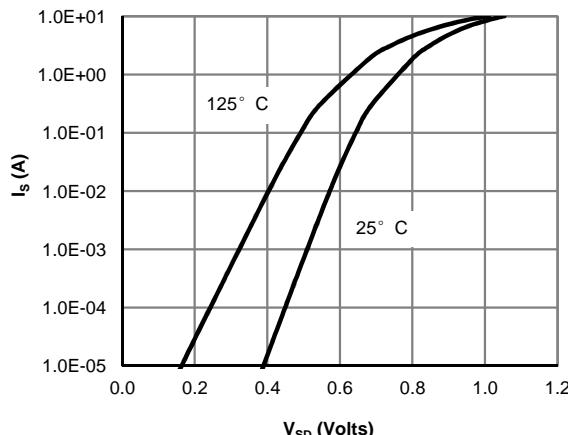
C. Repetitive rating, pulse width limited by junction temperature  $\text{T}_{\text{J(MAX)}}=150^\circ\text{C}$ . Ratings are based on low frequency and duty cycles to keep initial  $\text{T}_J=25^\circ\text{C}$ .

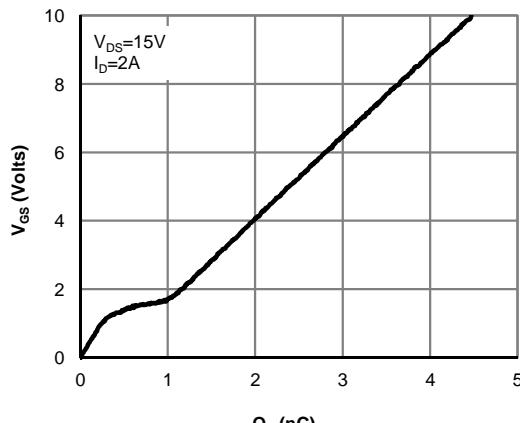
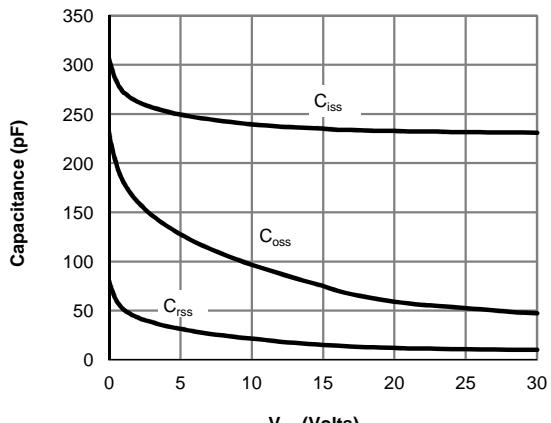
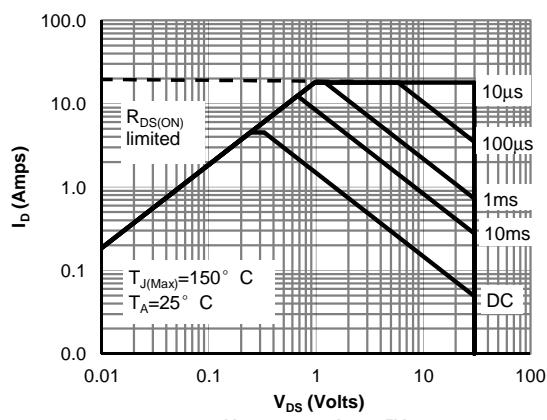
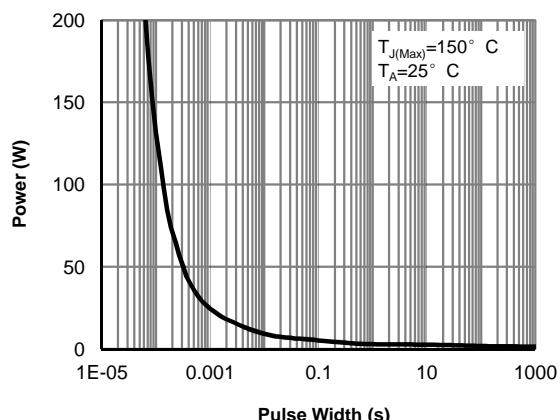
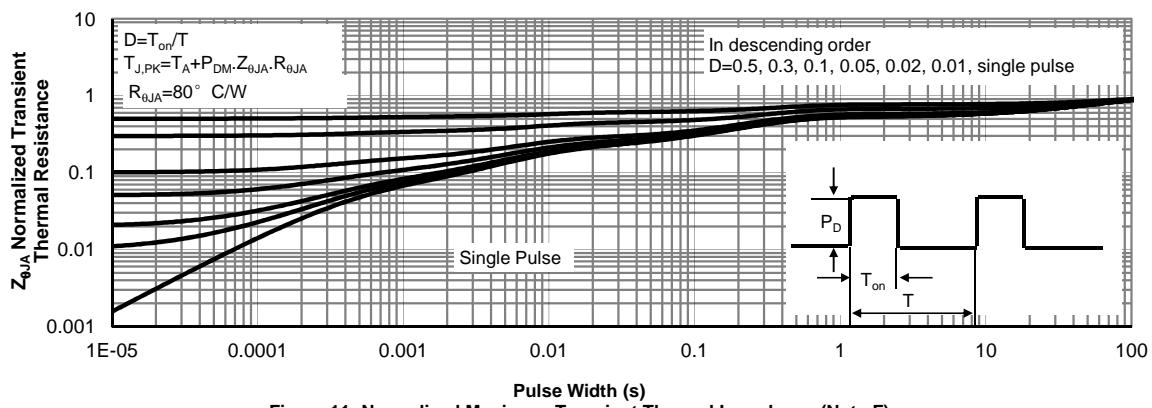
D. The  $\text{R}_{\text{QJA}}$  is the sum of the thermal impedance from junction to lead  $\text{R}_{\text{QUL}}$  and lead to ambient.

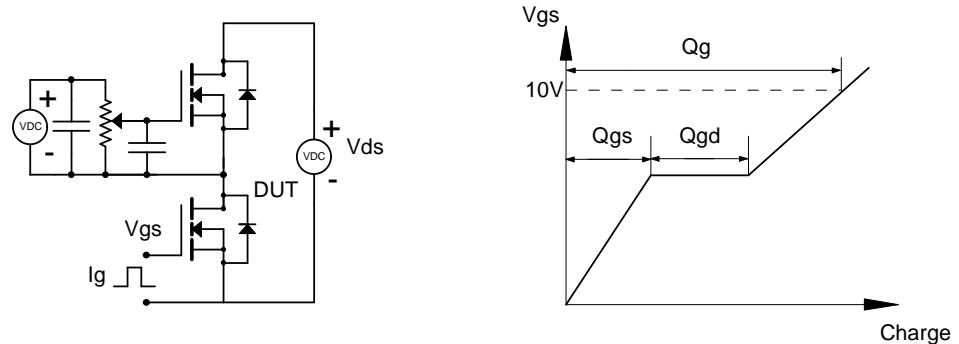
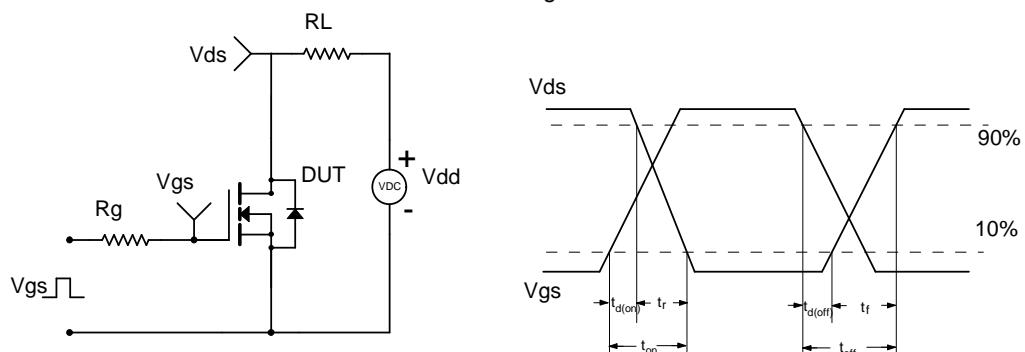
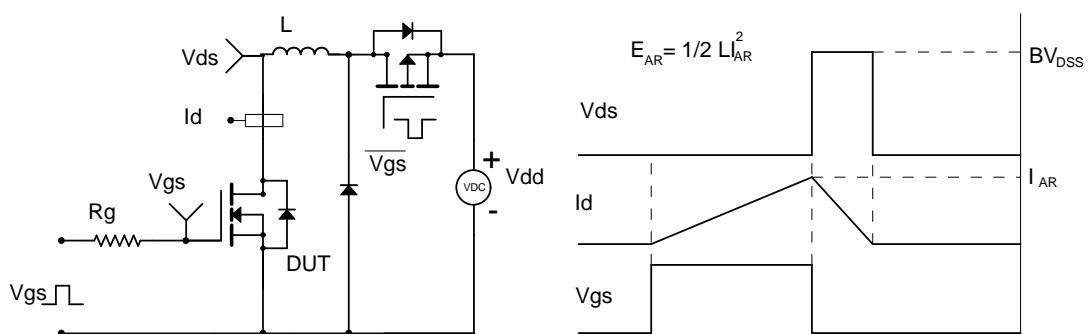
E. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $\text{T}_{\text{J(MAX)}}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

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**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 1: On-Region Characteristics (Note E)**

**Figure 2: Transfer Characteristics (Note E)**

**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**

**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

**Figure 6: Body-Diode Characteristics (Note E)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 7: Gate-Charge Characteristics**

**Figure 8: Capacitance Characteristics**

**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**

**Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)**

**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

**Gate Charge Test Circuit & Waveform**

**Resistive Switching Test Circuit & Waveforms**

**Unclamped Inductive Switching (UIS) Test Circuit & Waveforms**

**Diode Recovery Test Circuit & Waveforms**
